

PBSS9110AS

100 V, 1 A PNP low V_{CEsat} (BISS) transistor Rev. 03 — 21 November 2009

Product data sheet

Product profile

1.1 General description

PNP low V_{CEsat} (BISS) transistor in a SOT54 (SC-43/TO-92) plastic package.

1.2 Features

- SOT54 package
- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High efficiency leading to less heat generation

1.3 Applications

- Major application segments:
 - Automotive 42 V power
 - ◆ Telecom infrastructure
 - Industrial
- Peripheral driver:
 - ◆ Driver in low supply voltage applications (e.g. lamps and LEDs)
 - Inductive load driver (relays, buzzers and motors)
- DC-to-DC converter

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage		-	-	-100	V
I _C	collector current (DC)		-	-	–1	Α
I _{CM}	peak collector current		-	-	-3	Α
R _{CEsat}	equivalent on-resistance		-	-	320	mΩ



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Pinning information 2.

Table 2. **Discrete pinning**

Pin	Description	Simplified outline	Symbol
1	collector		
2	base		1
3	emitter		2 ————————————————————————————————————

3. **Ordering information**

Table 3. **Ordering information**

Type number	Package			
	Name	Description	Version	
PBSS9110AS	-	plastic single-ended leaded (through hole) package; 3 leads	SOT54	

Marking 4.

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Table 4. **Marking**

Type number	Marking code
PBSS9110AS	9110AS[1]

[1] Made in Hong Kong

Limiting values 5.

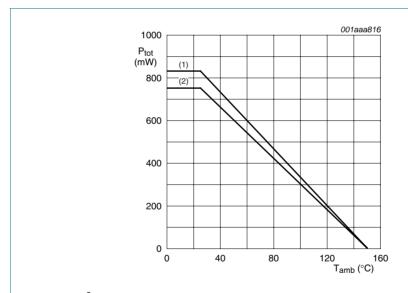
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Table 5. **Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V_{CBO}	collector-base voltage	open emitter		-	-120	V
V_{CEO}	collector-emitter voltage	open base		-	-100	V
V_{EBO}	emitter-base voltage	open collector		-	- 5	V
I _{CM}	peak collector current	T _{j(max)}		-	-3	Α
I _C	collector current (DC)			-	–1	Α
I _B	base current (DC)			-	-0.3	Α
P _{tot}	total power dissipation	$T_{amb} \le 25 ^{\circ}C$	[1]	-	830	mW
T_j	junction temperature			-	150	°C
T _{amb}	operating ambient temperature			-65	+150	°C
T_{stg}	storage temperature		,	-65	+150	°C

[1] Device mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, standard footprint.



- (1) 1cm² collector mounting pad
- Standard footprint

Power derating curves Fig 1.

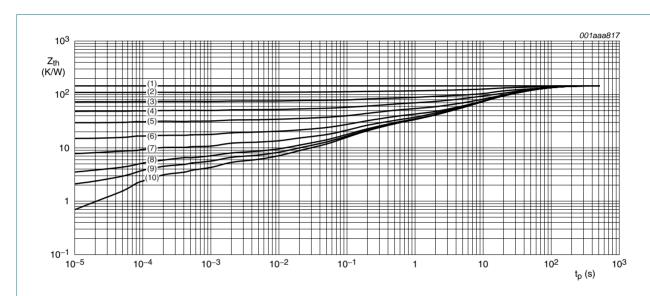
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Thermal characteristics

Thermal characteristics Table 6.

Symbol	Parameter	Conditions	Тур	Unit	
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	<u>11</u> 150	K/W	

[1] Device mounted on a FR4 printed-circuit board, single-sided copper, tin-plated, standard footprint.



Mounted on FR4 PCB; standard footprint

- (2) $\delta = 0.75$
- (3) $\delta = 0.5$
- (4) $\delta = 0.33$
- (5) $\delta = 0.2$
- (6) $\delta = 0.1$
- (7) $\delta = 0.05$
- (8) $\delta = 0.02$
- (9) $\delta = 0.01$
- (10) $\delta = 0$

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Transient thermal impedance as a function of pulse time; typical values

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Characteristics

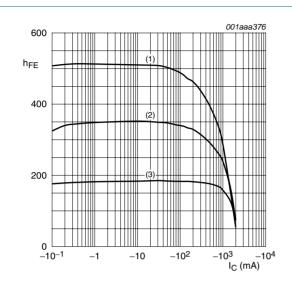
Table 7. Characteristics

T_{amb} = 25 °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I_{CBO}	collector-base cut-off current	$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A}$	-	-	-100	nA
		$V_{CB} = -80 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 \text{ °C}$	-	-	-50	μΑ
I _{CES}	collector-emitter cut-off current	$V_{CE} = -80 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	-100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = -4 \text{ V}; I_{C} = 0 \text{ A}$	-	-	-100	nA
h _{FE}	DC current gain	$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ mA}$	150	-	-	
		$V_{CE} = -5 \text{ V}; I_{C} = -250 \text{ mA}$	150		-	
		$V_{CE} = -5 \text{ V}; I_{C} = -0.5 \text{ A}$	<u>[1]</u> 150	-	450	
		$V_{CE} = -5 \text{ V}; I_{C} = -1 \text{ A}$	<u>[1]</u> 125	-	-	
V_{CEsat}	collector-emitter saturation	$I_C = -250 \text{ mA}; I_B = -25 \text{ mA}$	-	-	-120	mV
	voltage	$I_C = -500 \text{ mA}; I_B = -50 \text{ mA}$	-	-	-180	mV
		$I_C = -1 A$; $I_B = -100 \text{ mA}$	-	-	-320	mV
R _{CEsat}	equivalent on-resistance	$I_C = -1 A$; $I_B = -100 \text{ mA}$	<u>[1]</u> _	170	320	mΩ
V_{BEsat}	base-emitter saturation voltage	$I_C = -1 A$; $I_B = -100 \text{ mA}$	-	-	-1.1	V
V_{BEon}	base-emitter turn-on voltage	$I_C = -1 A; V_{CE} = -5 V$	-	-	-1.0	V
f _T	transition frequency	$I_C = -50 \text{ mA}; V_{CE} = -10 \text{ V};$ f = 100 MHz	100	-	-	MHz
C _c	collector capacitance	$I_E = I_e = 0 \text{ A}; V_{CB} = -10 \text{ V};$ f = 1 MHz	-	-	17	pF

^[1] Pulse test $t_p \le 300 \ \mu s$; $\delta \le 0.02$.

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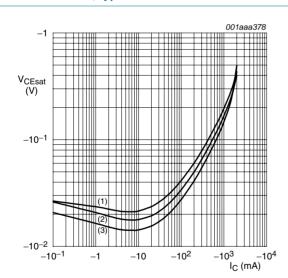
$$V_{CE} = -10 \text{ V}$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 3. DC current gain as a function of collector current; typical values



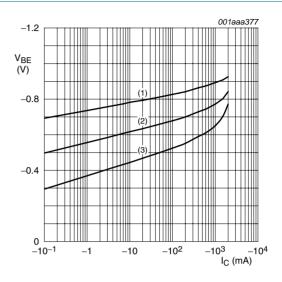
$$I_{\rm C}/I_{\rm B} = 10$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 5. Collector-emitter saturation voltage as a function of collector current; typical values



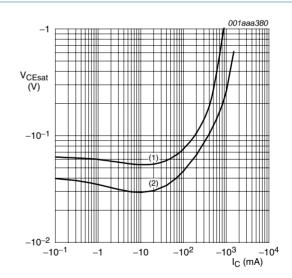
$$V_{CE} = -10 \text{ V}$$

(1)
$$T_{amb} = -55 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = 100 \, ^{\circ}C$$

Fig 4. Base-emitter voltage as a function of collector current; typical values



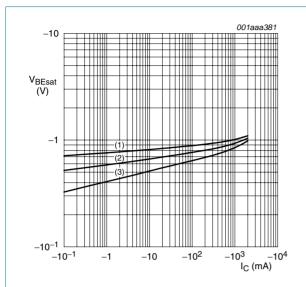
$$T_{amb} = 25 \, ^{\circ}C$$

(1)
$$I_C/I_B = 50$$

(2)
$$I_C/I_B = 20$$

Fig 6. Collector-emitter saturation voltage as a function of collector current; typical values

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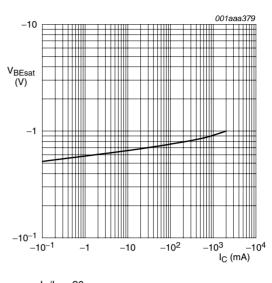
$$I_{\rm C}/I_{\rm B} = 10$$

(1)
$$T_{amb} = -55 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = 100 \, ^{\circ}C$$

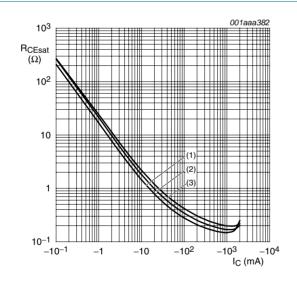
Fig 7. Base-emitter saturation voltage as a function of collector current; typical values



$$I_C/I_B = 20$$

 $T_{amb} = 25 \, ^{\circ}C$

Fig 8. Base-emitter saturation voltage as a function of collector current; typical values



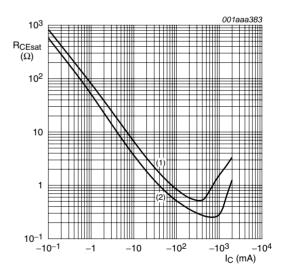


(1)
$$T_{amb} = -55 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3)
$$T_{amb} = 100 \, ^{\circ}C$$

Fig 9. Equivalent on-resistance as a function of collector current; typical values



$$T_{amb} = 25 \, ^{\circ}C$$

- (1) $I_C/I_B = 50$
- (2) $I_C/I_B = 20$

Fig 10. Equivalent on-resistance as a function of collector current; typical values

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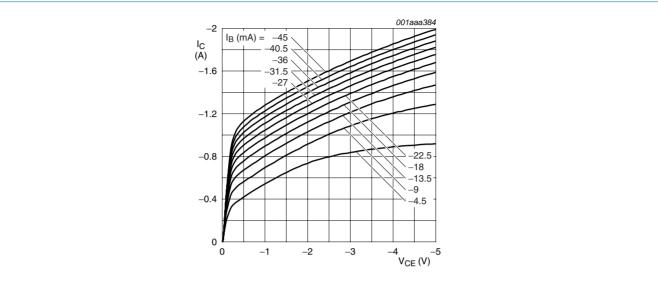
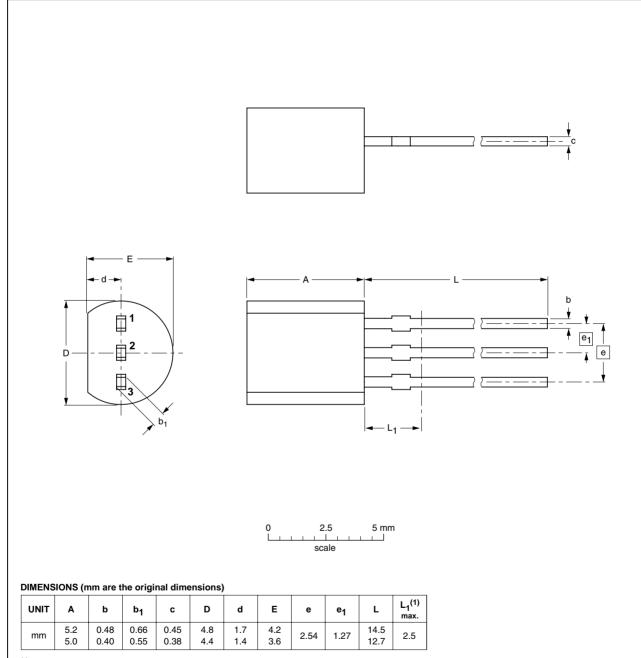


Fig 11. Collector current as a function of collector-emitter voltage; typical values

8. Package outline

Plastic single-ended leaded (through hole) package; 3 leads

SOT54



Note

1. Terminal dimensions within this zone are uncontrolled to allow for flow of plastic and terminal irregularities.

OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	JEITA	PROJECTION	ISSUE DATE
SOT54		TO-92	SC-43A		04-06-28 04-11-16

Fig 12. Package outline

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Revision history

Table 8. **Revision history**

Product data sheet

Document ID	Release date	Data sheet status	Change notice	Supersedes		
PBSS9110S_3	20091121	Product data sheet	-	PBSS9110S_2		
Modifications:		et was changed to reflect the legal definitions and disclain				
	 Figure 9 "Equ 	<u>ivalent on-resistance as a fu</u>	nction of collector curr	ent; typical values": updated		
	• Figure 10 "Equivalent on-resistance as a function of collector current; typical values": updated					
	• Figure 11 "Co	llector current as a function	of collector-emitter volt	age; typical values": updated		
	• Figure 12 "Pa	ckage outline": updated				
PBSS9110S_2	20040816	Product data sheet	-	PBSS9110AS_1		
PBSS9110AS_1	20040610	Product data sheet	-	-		

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10.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- [1] Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions"
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